

Application/Control No.	Applicant(s)/Patent (Reexamination	under
10/758,224	MORIYAMA ET AL	
Examiner	Art Unit	
Luan V. Van	1795	

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(ORIGINAL		CROSS REFERENCE(S)											
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)											
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INTERNATIO	NAL CLASSIFICATION													
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LUAN V	. VAN I/I	7/0g	na	NAM NG	CMT PYAM	Total Claims Allowed:								
(Legal Ins	struments Examiner) (Date)	TECI	NOLOGY C	ENT EXAM ENTER 170	O. Print C		O.G. Print Fig.						

	Claims renumbered in the same order as presented by applicant										ОС	PA	☐ T.D.			☐ R.1.47		
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	18			48			78			108			138		168			198
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